Search Notes



Application/Control No.	Applicant(s)/Patent under Reexamination	
10/612,243	QIAN ET AL.	
Examiner	Art Unit	
John L. Goodrow	1756	

SEARCHED					
Class	Subclass	Date	Examiner		
430	109.31	6/5/2006	JG		
	109.1				
	109.3				
	120				
	137.1				
			•		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
430	109.31	6/5/2006	JG	
	109.1 &3			
	120			
430/	137.1			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
inventor name search and east	6/5/2006	JG		